

## Recent developments of RIKEN 28 GHz SC-ECRIS†

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In the past two years, we have attempted to improve the performance of RIKEN 28GHz SC-ECRIS for the production of an intense U ion beam. Last year, we produced  $\sim 200$   $\mu\text{A}$  of  $\text{U}^{35+}$  at an injected radio frequency (RF) power of  $\sim 2.6$  kW. For the RIKEN RIBF experiment, we produced  $\sim 110$   $\mu\text{A}$  of  $\text{U}^{35+}$  ions with the sputtering method for longer than one month without interruption. In this case, we surely require a very stable beam to increase the transmission efficiency in the accelerators and avoid any damage to the components of the accelerator due to the high-power beam. Very recently, we tested the production of a highly charged Zn ion beam to meet the requirements of the RIBF project and to produce an intense beam with a very low consumption rate.

Figures 1(a) and (b) show the extraction current of the ion source and the beam intensity of  $\text{U}^{35+}$  ions, respectively. The extracted current is quite stable, and the average beam intensity of  $\text{U}^{35+}$  was  $\sim 102$   $\mu\text{A}$  over a long period of time. Under this condition, a maximum beam intensity of  $\sim 49$   $\mu\text{A}$  was successfully extracted from the superconducting ring cyclotron for the RIBF experiment conducted last autumn<sup>1)</sup>.

For long-term operation, it is important to minimize the

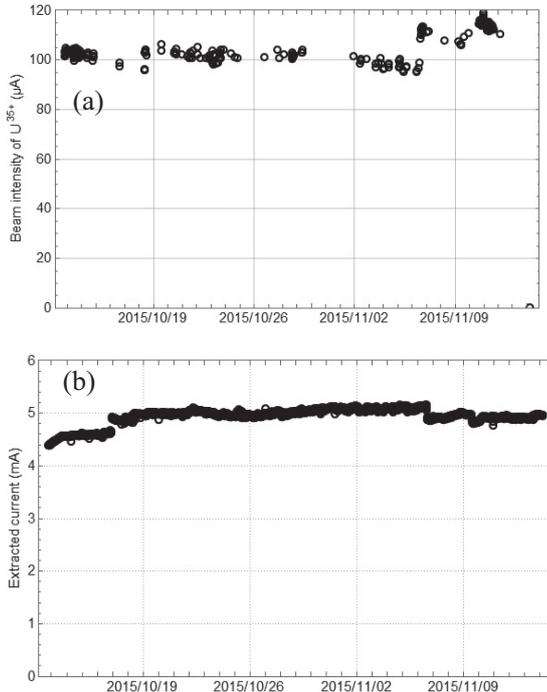


Fig. 1. (a) Beam intensity of  $\text{U}^{35+}$  ions and (b) the extracted current as a function of time.

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material consumption rate. To obtain the consumption rate, we operated the ion source with the same sputtering voltage for approximately one month. In 2012, we produced an intense beam of  $\text{U}^{35+}$  with a sputtering voltage of approximately  $-5$  kV. In this experiment, we observed that the consumption rate of the material is higher than that in the oven method<sup>2)</sup>. To minimize the consumption rate while maintaining the beam intensity, we systematically studied the consumption rate for several sputtering voltages. At a sputtering voltage of  $-1$  kV, the consumption rate was  $\sim 2.1$  mg/h for the production of approximately 100  $\mu\text{A}$  of  $\text{U}^{35+}$  ions, which is significantly lower than the consumption rate at approximately  $-5$  kV ( $\sim 5$  mg/h).

For the production of Zn vapor, we used a low-temperature oven<sup>3)</sup> of the same type as that used for the 18 GHz ECRIS at RIKEN. In the test experiment, we used He gas as a support gas and  $\text{natZnO}$  as a sample. Fig. 2 shows the typical charge distribution of the highly charged Zn ions. The injected RF power was  $\sim 1.6$  kW (28 GHz + 18 GHz).  $B_{\text{inj}}$ ,  $B_{\text{min}}$ ,  $B_{\text{ext}}$ , and  $B_{\text{r}}$ <sup>4)</sup> were 3.1, 0.62, 1.78, and 1.94 T, respectively, and the typical gas pressure was  $6.5\text{--}7.5 \times 10^{-5}$  Pa. The average beam intensity was  $\sim 26$   $\mu\text{A}$  of  $^{64}\text{Zn}^{19+}$  ions, which is the required charge state of the Zn ions for RIBF experiments. The consumption rate of Zn was  $\sim 0.20$  mg/h. If we assume the use of enriched  $^{70}\text{Zn}$ , the beam intensity will be  $\sim 60$   $\mu\text{A}$ , which is the required beam intensity. (the natural abundance of  $^{64}\text{Zn}$  is about 48.6 %) Furthermore, the consumption rate for 28 GHz SC-ECRIS was almost same as that for 18 GHz ECRIS.

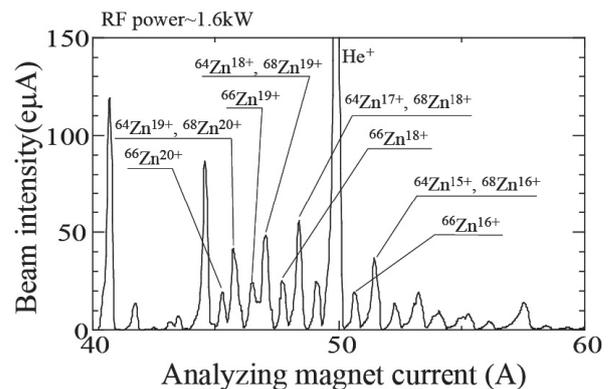


Fig. 2. Charge distribution of the highly charged Zn ion beam.

### References

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